

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10575425	PROUET ET AL.
	Examiner	Art Unit
	JOHN W POOS	2816

SEARCHED

Class	Subclass	Date	Examiner
327	103	11/29/2007	JP
323	315	12/3/2007	JP

SEARCH NOTES

Search Notes	Date	Examiner
terms used to constrain subclasses above: chip, different sized transistors, transconductance, differential input voltage	11/29/2007	JP
Inventor search in EAST and eDAN	12/3/2007	JP
Update Search see attached Search History	4/25/2008	JP
Update Search: see attached EAST search history	10/10/2008	JP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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